Device Modeling Report

COMPONENTS: TRANSISTOR
PART NUMBER: US6T6TR
MANUFACTURER: ROHM

Bee Technologies Inc.

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TRANSISTOR MODEL

PSpice model parameter	Model description
IS	Saturation Current
BF	Ideal Maximum Forward Beta
NF	Forward Current Emission Coefficient
VAF	Forward Early Voltage
IKF	Forward Beta Roll-off Knee Current
ISE	Non-ideal Base-Emitter Diode Saturation Current
NE	Non-ideal Base-Emitter Diode Emission Coefficient
BR	Ideal Maximum Reverse Beta
NR	Reverse Emission Coefficient
VAR	Reverse Early Voltage
IKR	Reverse Beta Roll-off Knee Current
ISC	Non-ideal Base-Collector Diode Saturation Current
NC	Non-ideal Base-Collector Diode Emission Coefficient
NK	Forward Beta Roll-off Slope Exponent
RE	Emitter Resistance
RB	Base Resistance
RC	Series Collector Resistance
CJE	Zero-bias Emitter-Base Junction Capacitance
VJE	Emitter-Base Junction Potential
MJE	Emitter-Base Junction Grading Coefficient
CJC	Zero-bias Collector-Base Junction Capacitance
VJC	Collector-base Junction Potential
MJC	Collector-base Junction Grading Coefficient
FC	Coefficient for Onset of Forward-bias Depletion Capacitance
TF	Forward Transit Time
XTF	Coefficient for TF Dependency on Vce
VTF	Voltage for TF Dependency on Vce
ITF	Current for TF Dependency on Ic
PTF	Excess Phase at f=1/2pi*TF
TR	Reverse Transit Time
EG	Activation Energy
XTB	Forward Beta Temperature Coefficient
XTI	Temperature Coefficient for IS

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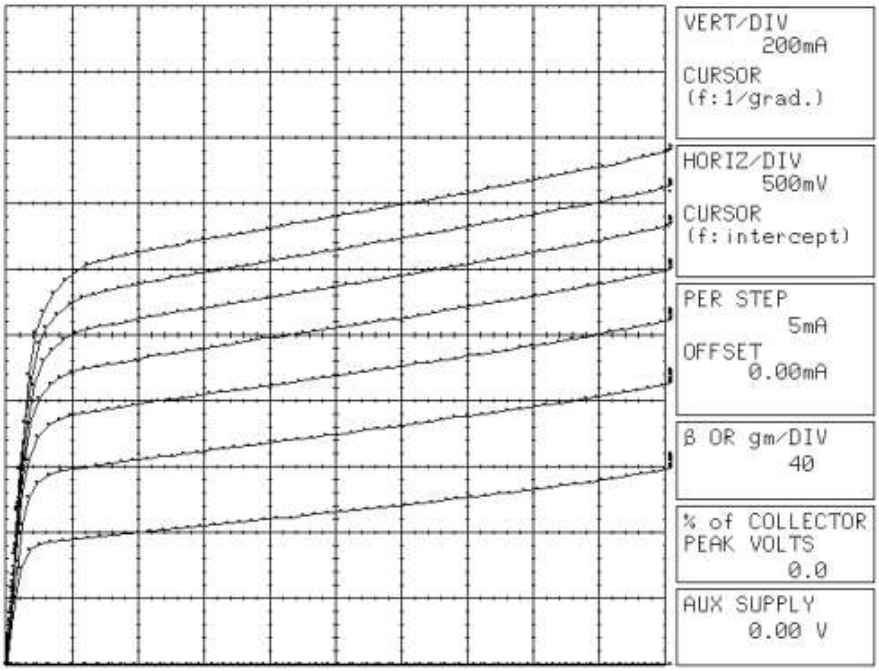
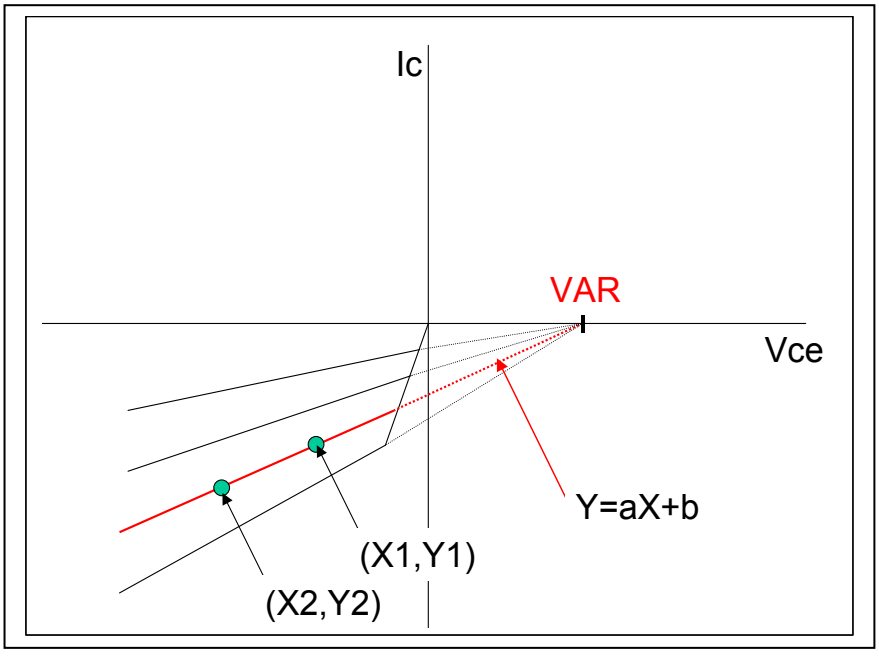
Reverse

Reverse Early Voltage Characteristic





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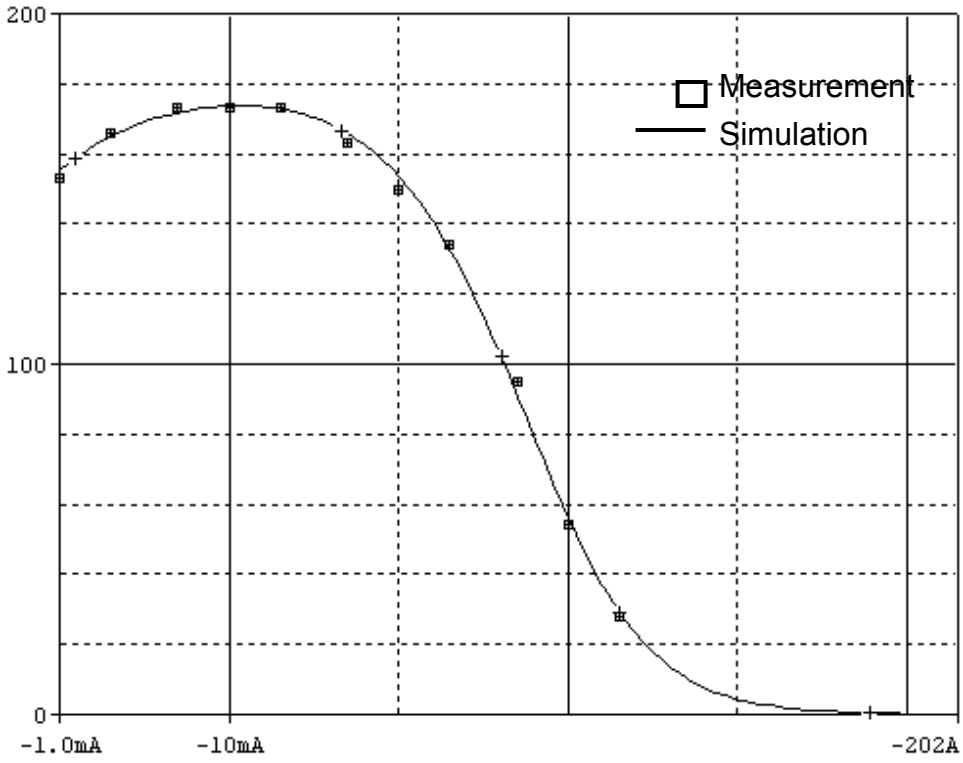
Reverse DC Beta Characteristic (Ie vs. h_{FE})



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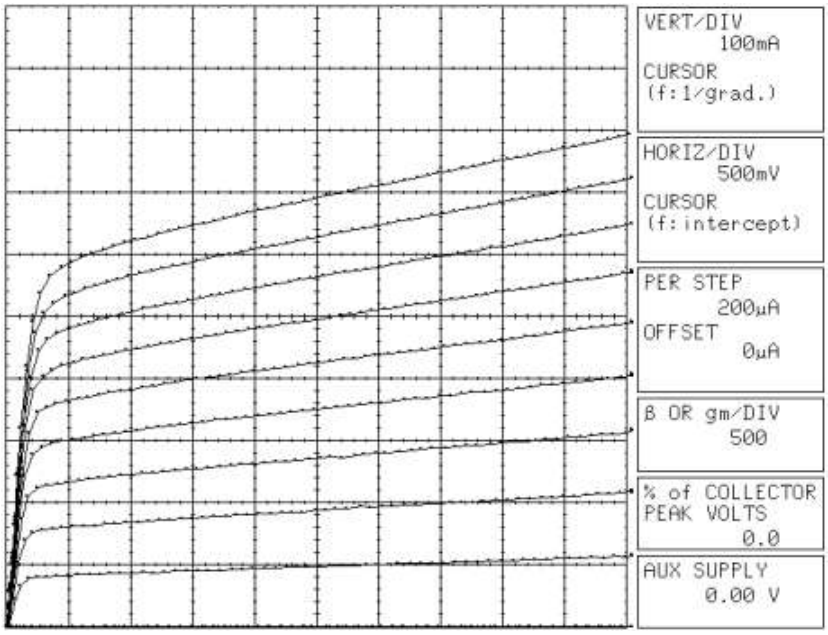
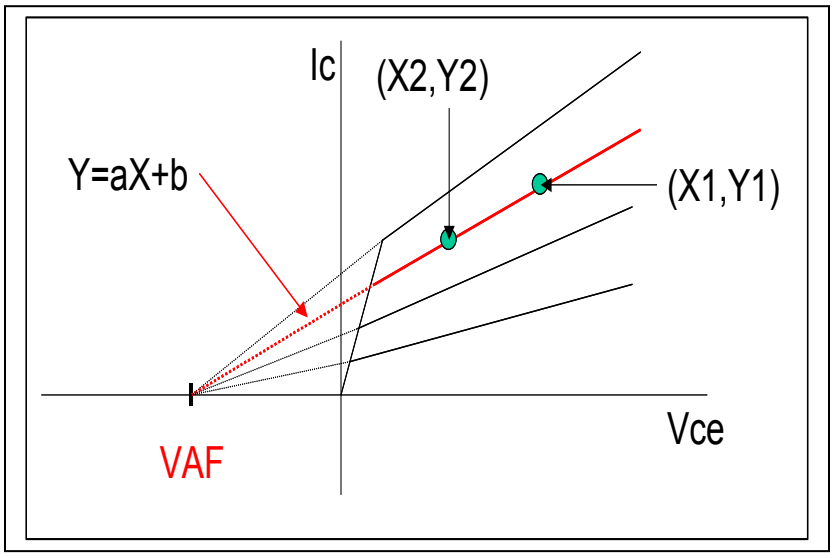
Forward

Forward Early Voltage Characteristic





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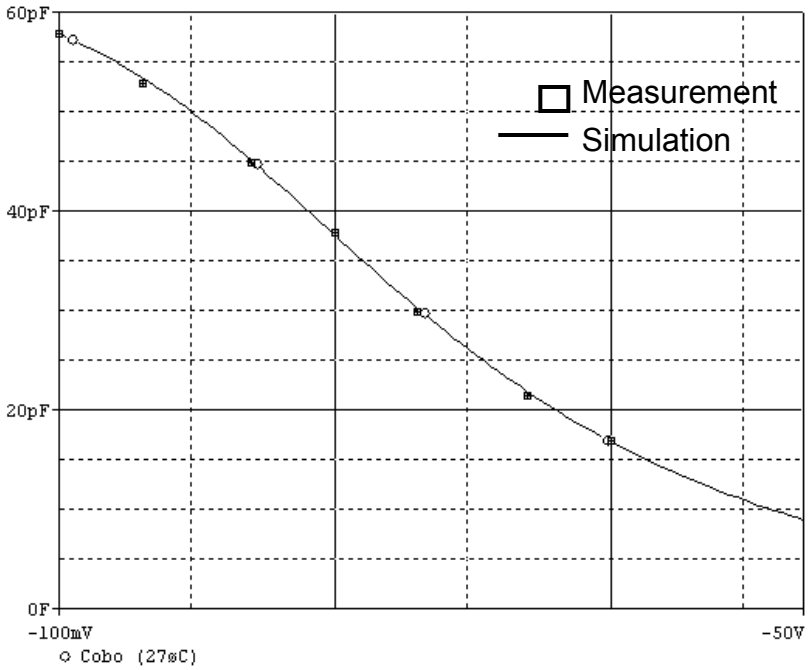
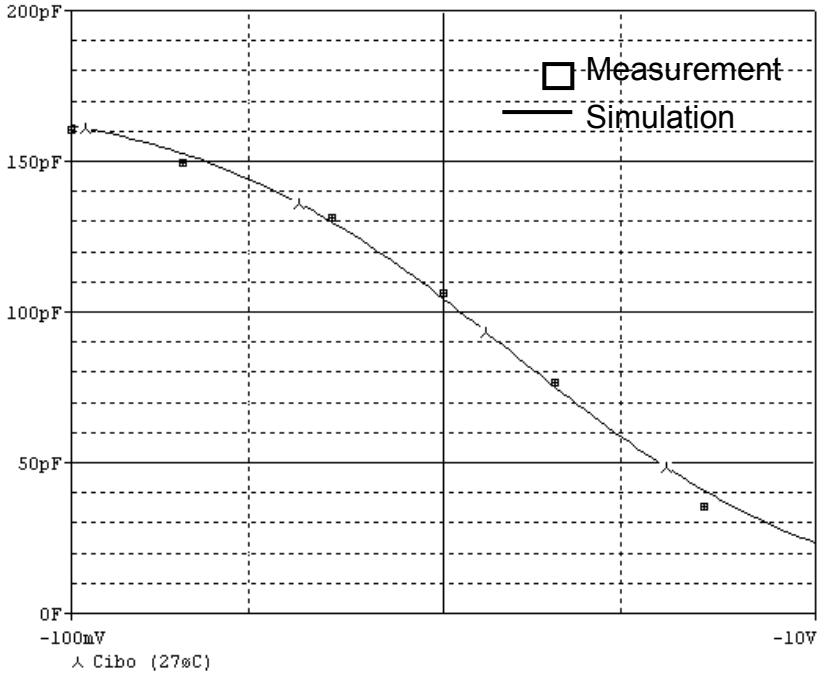
C-B Capacitance Characteristics



E-B Capacitance Characteristics



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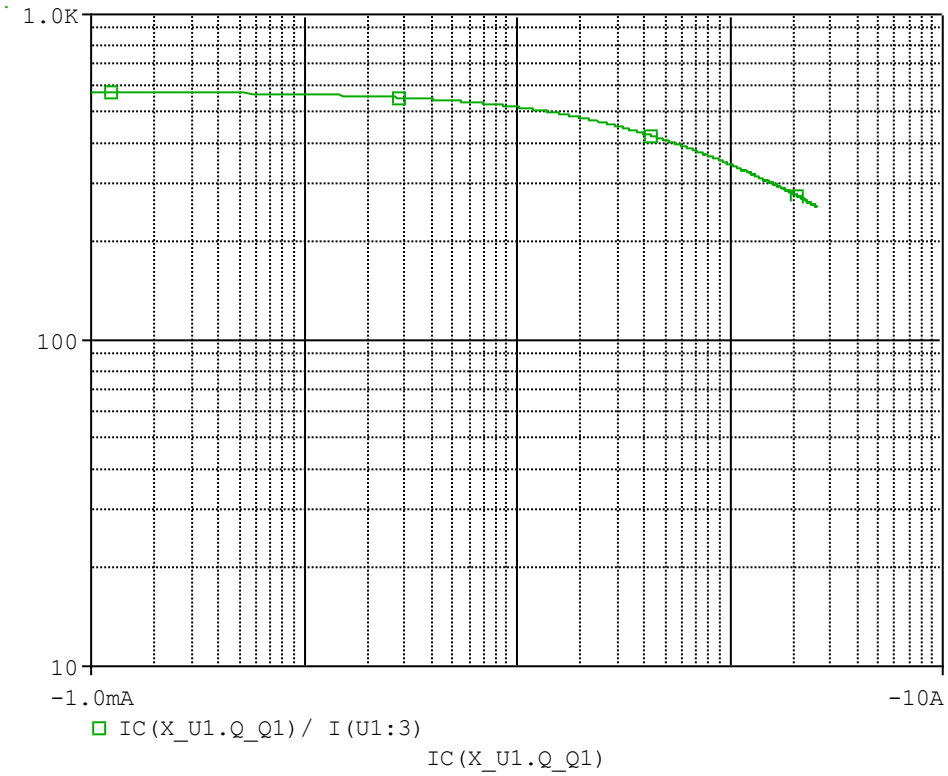
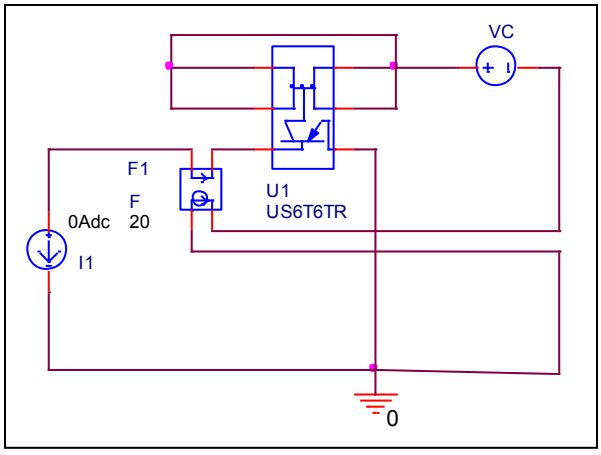
Transistor h_{FE}-I_C Characteristics

Circuit Simulation Result



Evaluation Circuit



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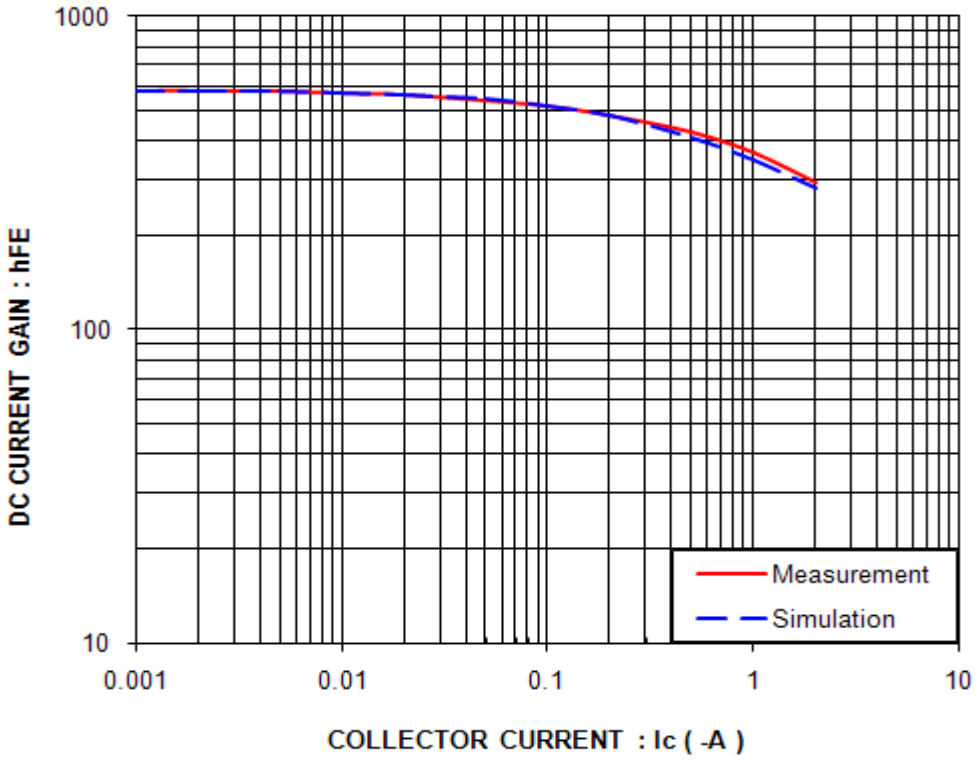
Comparison Graph

Circuit Simulation Result



Simulation Result

Ic(A)	hFE		Error(%)
	Measurement	Simulation	
-0.001	580.000	578.681	-0.227
-0.002	580.000	576.619	-0.583
-0.005	575.000	572.750	-0.391
-0.010	565.000	568.268	0.578
-0.020	560.000	561.064	0.190
-0.050	535.000	543.381	1.567
-0.100	514.000	519.277	1.027
-0.200	480.000	481.871	0.390
-0.500	425.000	411.094	-3.272
-1.000	365.000	346.954	-4.944
-2.000	295.000	281.115	-4.707

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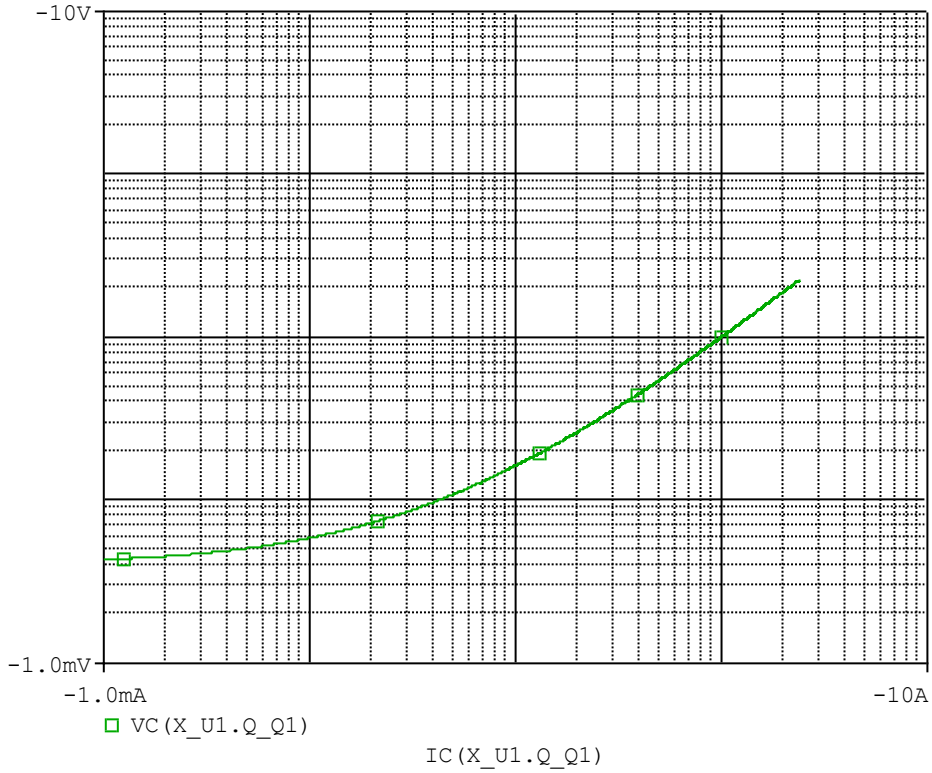
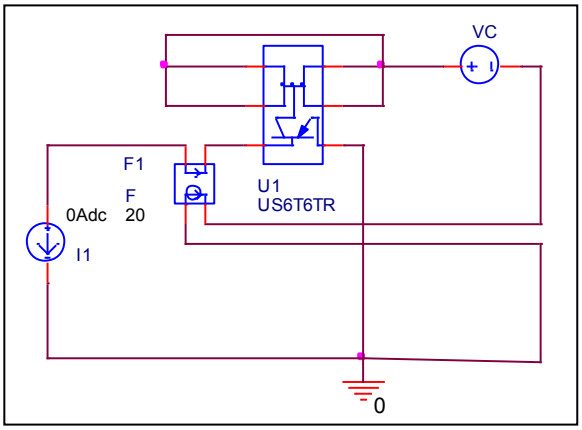
$V_{CE(Sat)}$-I_C Characteristics

Circuit Simulation Result



Evaluation Circuit



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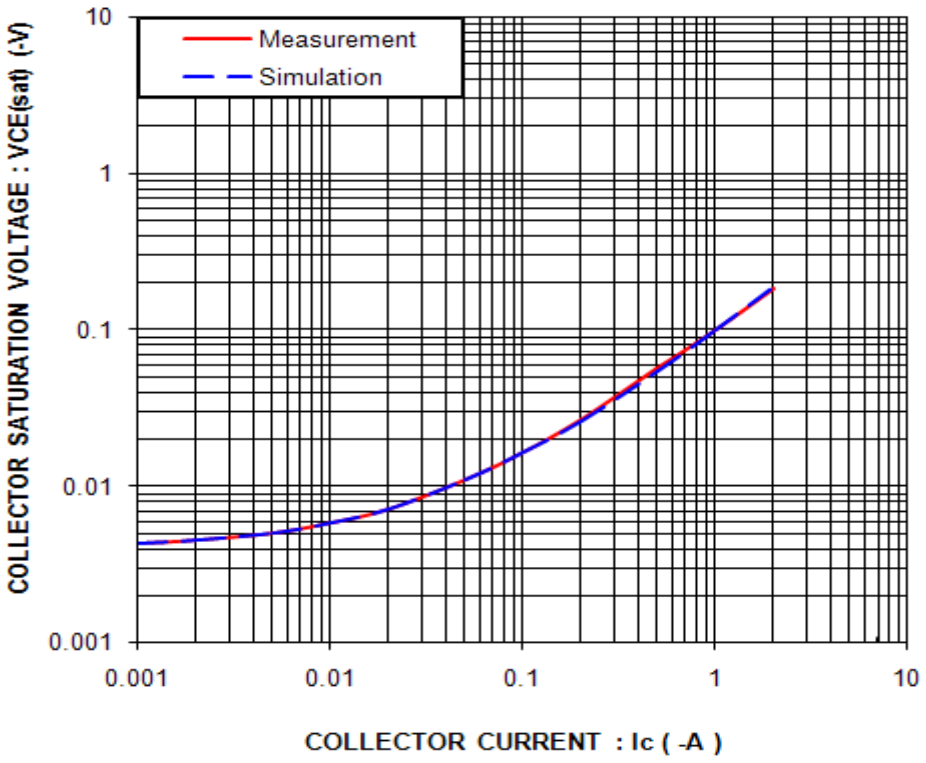
Comparison Graph

Circuit Simulation Result



Simulation Result

IC(A)	VCE(sat)(V)		Error(%)
	Measurement	Simulation	
-0.001	-0.0043	-0.0043	0.4651
-0.002	-0.0045	-0.0045	0.4444
-0.005	-0.0050	-0.0050	0.8000
-0.010	-0.0058	-0.0058	0.1724
-0.020	-0.0071	-0.0071	0.4225
-0.050	-0.0110	-0.0109	-0.9091
-0.100	-0.0165	-0.0163	-1.2121
-0.200	-0.0270	-0.0263	-2.4556
-0.500	-0.0565	-0.0548	-2.9735
-1.000	-0.1000	-0.1007	0.7000
-2.000	-0.1850	-0.1907	3.0924

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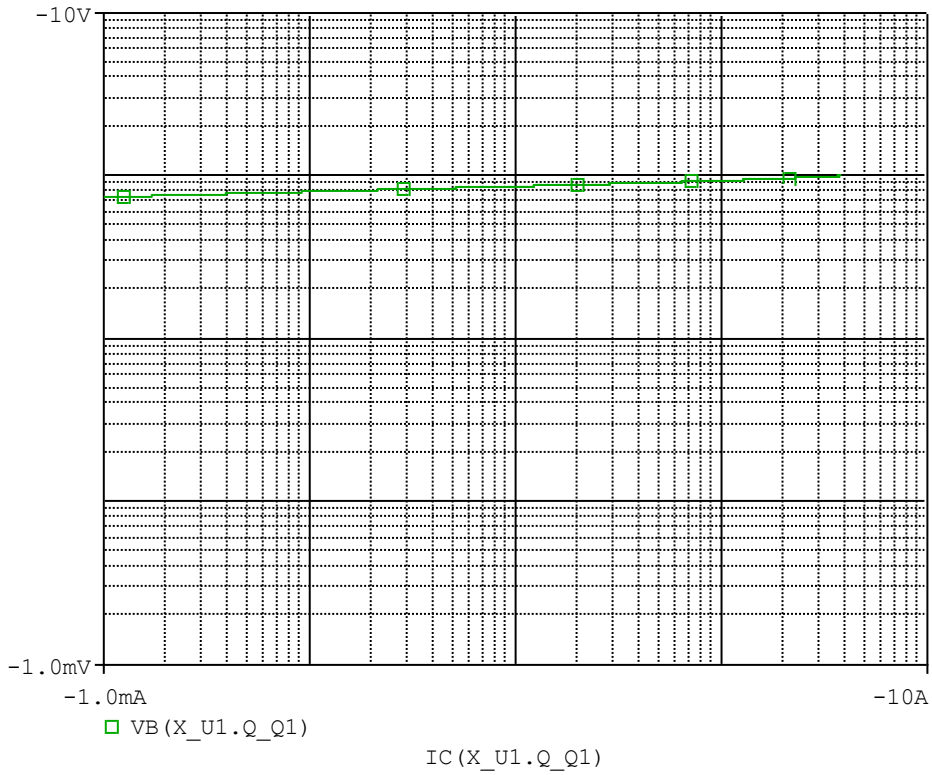
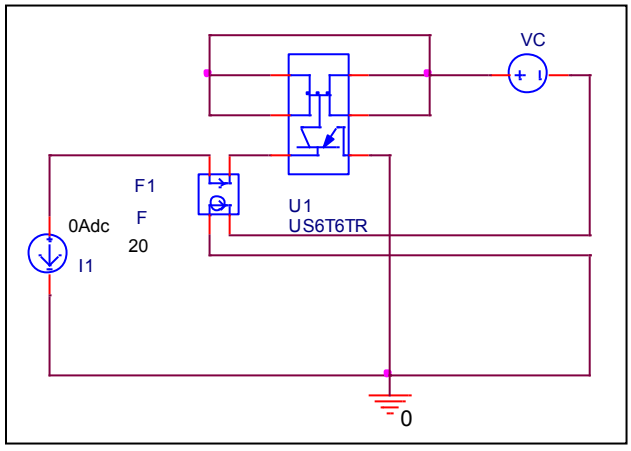
$V_{BE(Sat)}$-I_C Characteristics

Circuit Simulation Result



Evaluation Circuit



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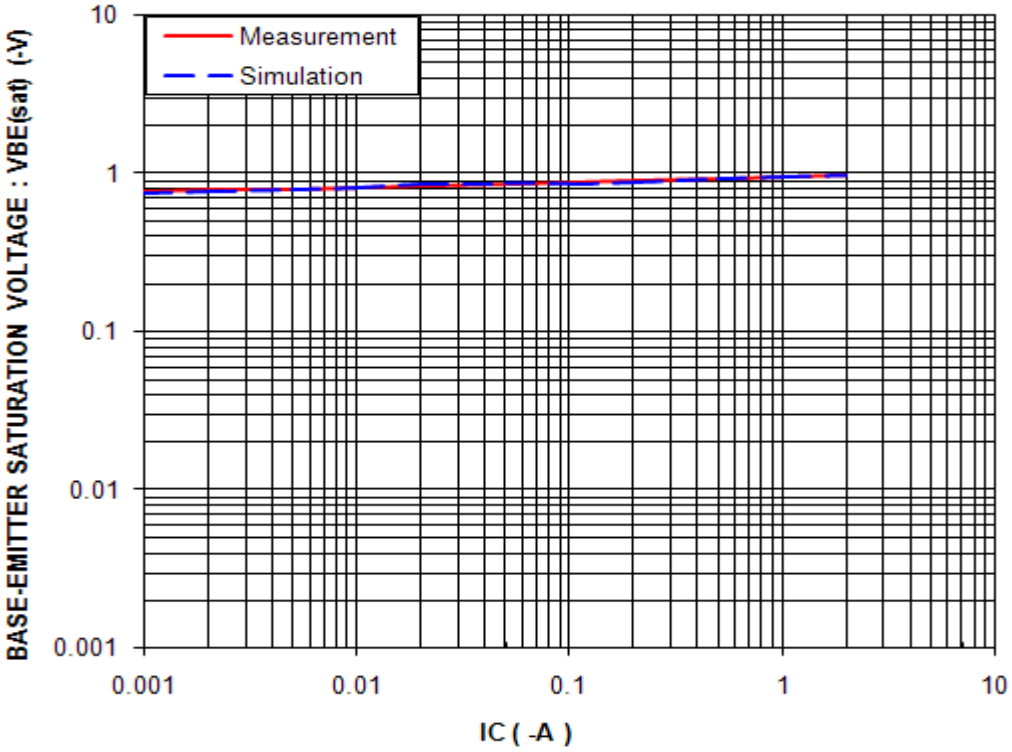
Comparison Graph

Circuit Simulation Result



Simulation Result

IC(A)	VBE(sat)(V)		Error(%)
	Measurement	Simulation	
-0.001	-0.770	-0.740	-3.896
-0.002	-0.785	-0.758	-3.439
-0.005	-0.795	-0.782	-1.635
-0.010	-0.815	-0.800	-1.840
-0.020	-0.825	-0.843	2.182
-0.050	-0.850	-0.862	1.412
-0.100	-0.870	-0.862	-0.920
-0.200	-0.890	-0.882	-0.899
-0.500	-0.910	-0.911	0.110
-1.000	-0.935	-0.935	0.000
-2.000	-0.960	-0.964	0.417

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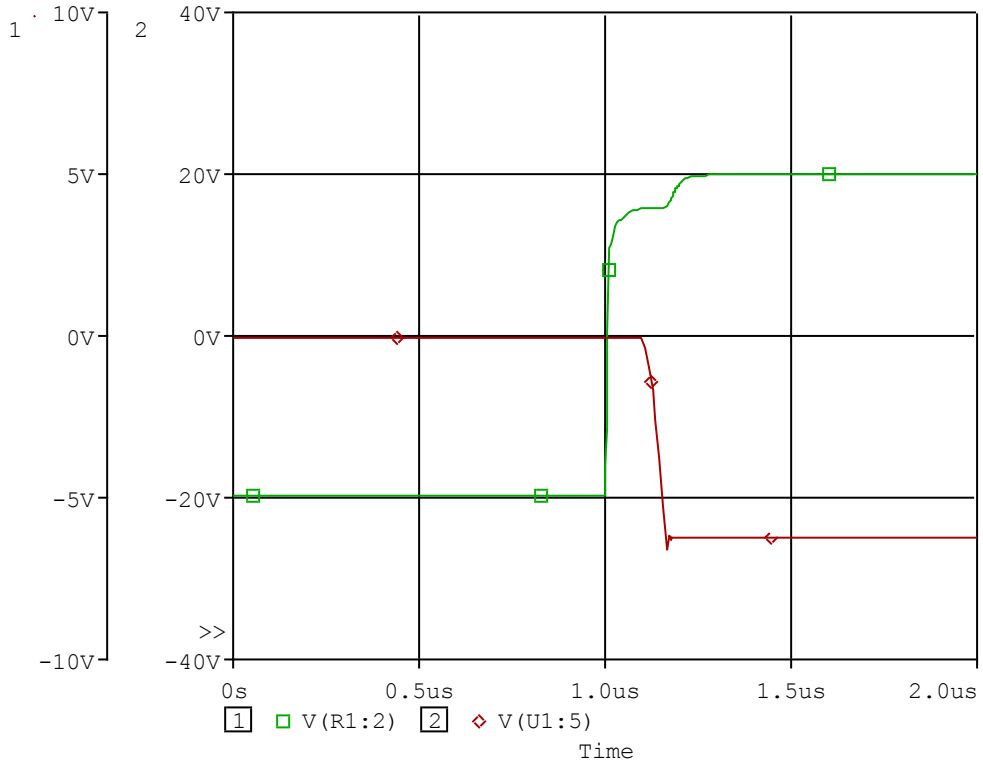
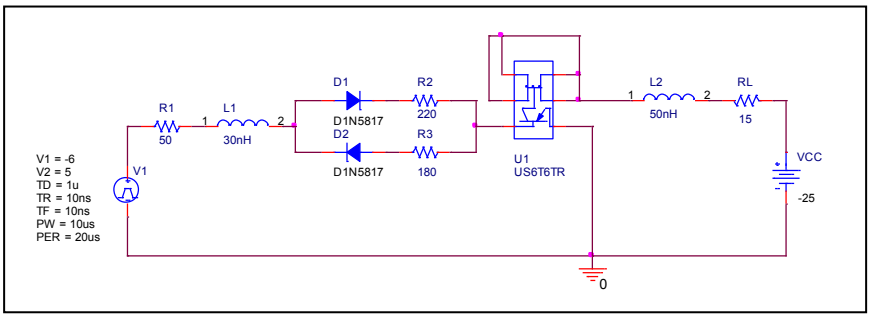
Switching Characteristics

Circuit simulation result



Evaluation circuit



Simulation result

	Measurement	Simulation	%Error
t_f (ns)	50.000	48.158	-3.684
t_{stg} (ns)	112.000	110.443	-1.390

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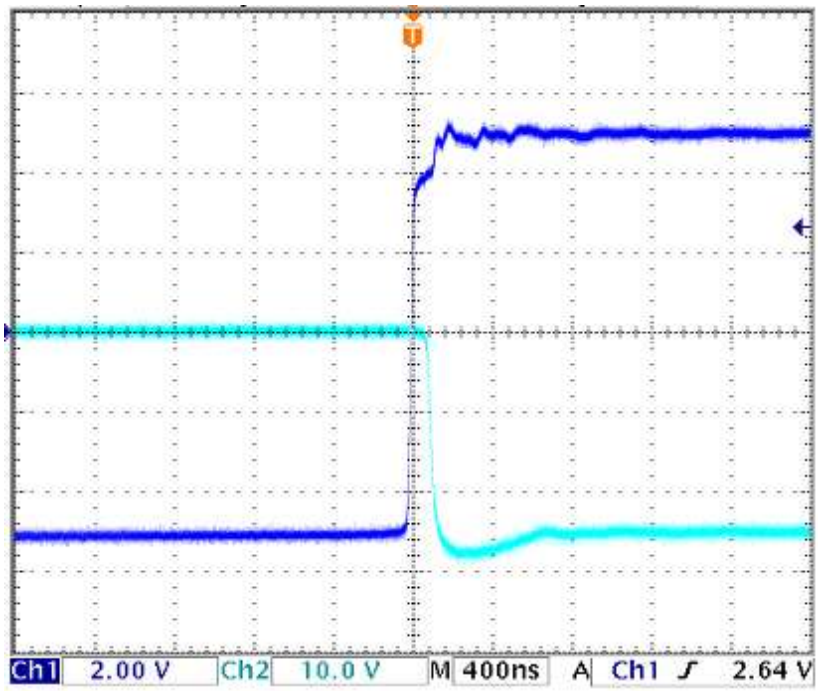
Switching Characteristics Reference



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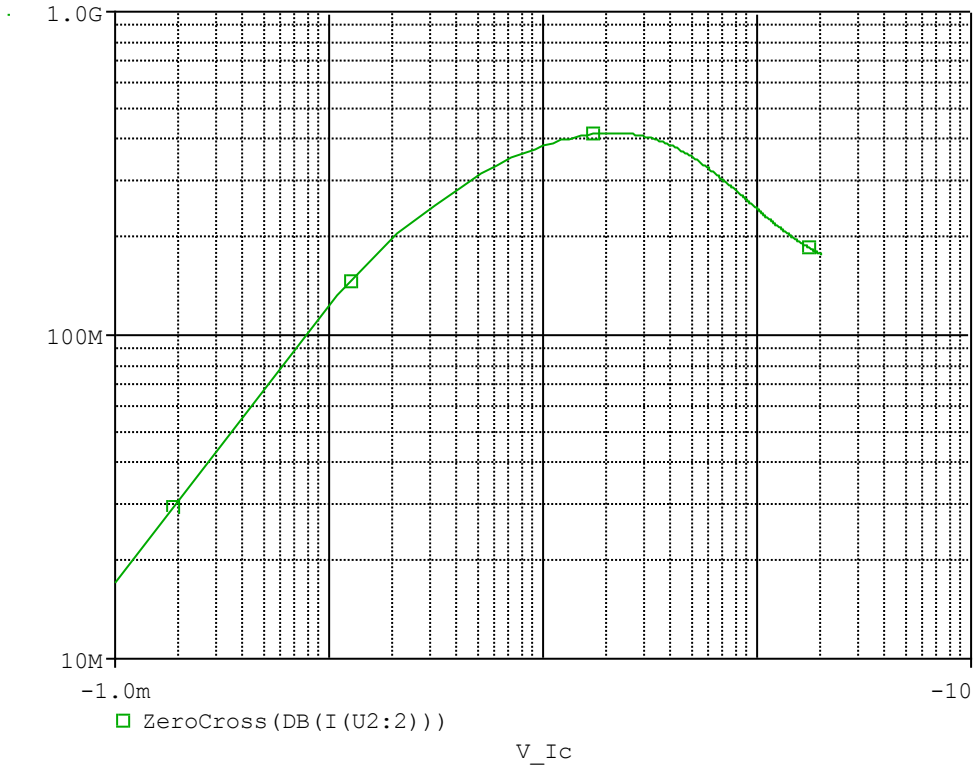
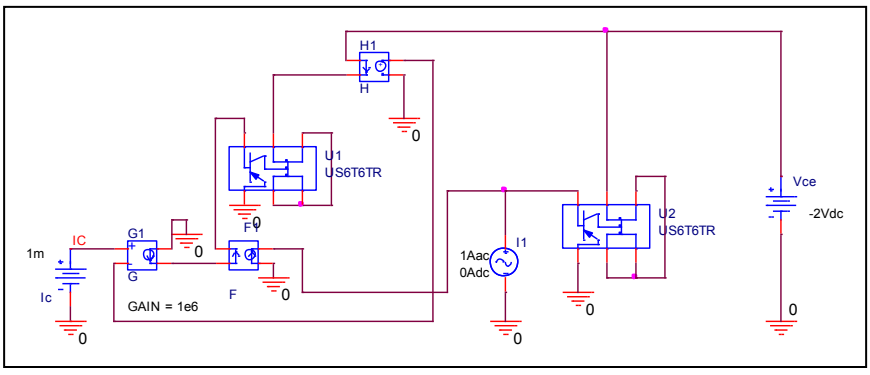
F_t - I_C Characteristics

Circuit Simulation Result



Evaluation Circuit



Simulation Result

IC(A)	FT(MHz)		Error(%)
	Measurement	Simulation	
-0.200	405.000	420.743	3.887

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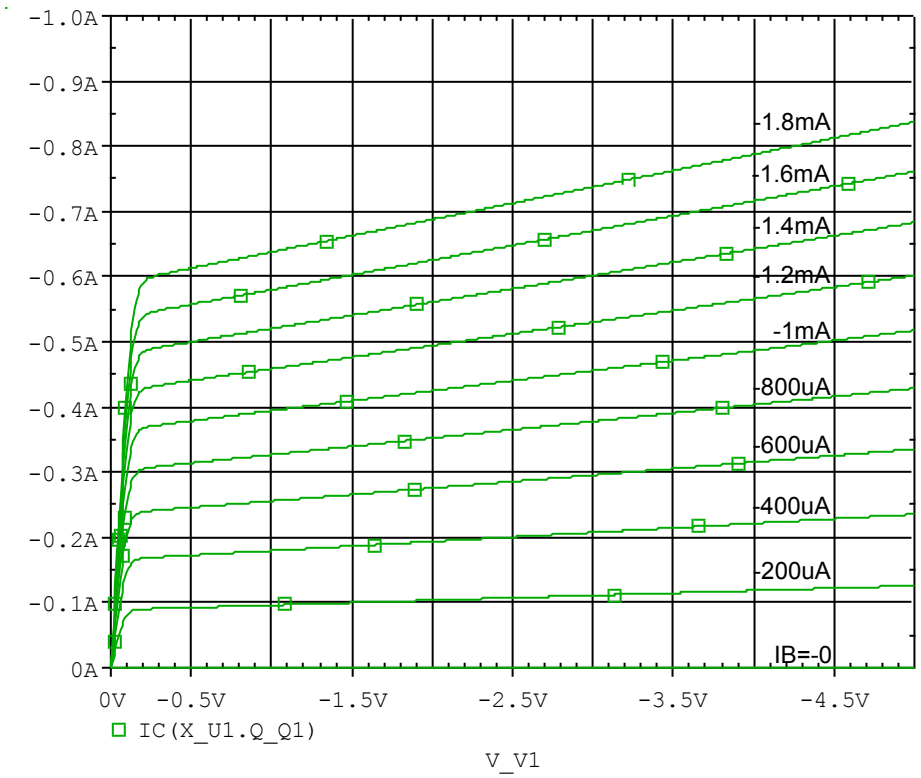
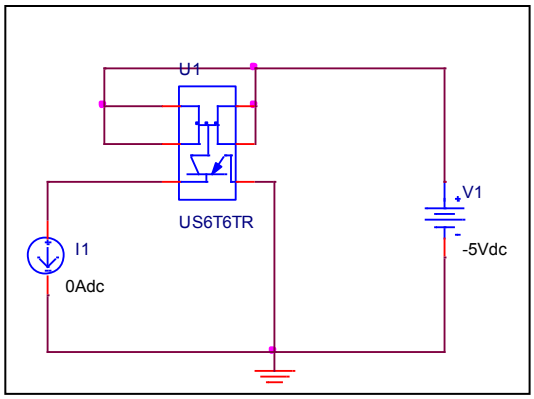
Output Characteristics

Circuit Simulation Result



Evaluation Circuit



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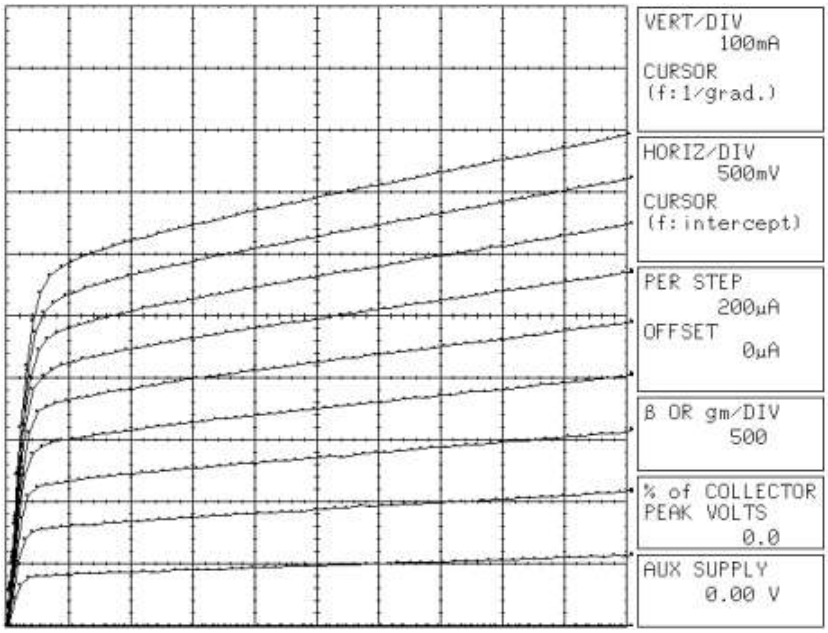
Output Characteristics Reference



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